

Applicant Initiated Interview Request Form – faxed to: 571. 270. 8538

In re the Application of

Masaharu KAWAKUBO et al.

Group Art Unit 2882

Application No.: 10/581,060

Examiner: C. RIDDLE

Filed: May 30, 2006

Docket No.: 127873

For: EXPOSURE METHOD AND DEVICE MANUFACTURING METHOD, EXPOSURE APPARATUS, AND PROGRAM

Tentative Participants:

(1) Michael D. Gagliano (2) Examiner Riddle
 (3) _____ (4) _____

Confirmed Date of Interview: 1-21-10 Proposed Time: 11:00 AM (AM/PM)

Type of Interview Requested:(1) Telephonic (2) Personal (3) Video ConferenceExhibit To Be Shown or Demonstrated: YES NO
If yes, provide brief description: _____**Issues To Be Discussed**

Issues (Rej., Obj., etc)	Claims/ Fig. #s	Prior Art	Discussed	Agreed	Not Agreed
(1) Objection to Specification	Claim 61		<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>
(2) 103(a)	Claims 31, 50 and 61	U.S. 2002/0042664 to Kikuchi in view of U.S. Patent No. 6,338,925 to Tomimatu, and further in view of U.S. Patent No. 5,808,910 to Irie et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>
(3) _____	_____	_____	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>

 Continuation Sheet Attached**Brief Description of Arguments to be Presented:**

(1) Regarding the objection to the specification for failing to provide proper antecedent basis for "a computer readable medium," as recited in independent claim 61, Applicants' assert that page 24, line 25 - page 25, line 16 of Applicants' specification discloses a computer, a storage unit and a processor, thereby providing proper antecedent basis for "a computer readable medium."

(2) Regarding the 35 U.S.C. §103(a) rejection of independent claims 31, 50 and 61, Applicants' assert that none of the applied references teach "with respect to every (K-1) lot of second and subsequent lots in the specific process, for a plurality of measurement divided areas on the photosensitive object that includes at least the plurality of specific divided areas, calculating a non-linear component of positional deviation amount of each of the measurement divided areas from the individual fiducial position based on an actual measurement value of positional information of each of the measurement divided areas and on the corresponding estimate value, updating the correction information as needed in accordance with a magnitude of one of the calculated non-linear component of

positional deviation amount of each of the measurement divided areas and a variation amount of the non-linear component, but not updating the correction information with respect to the remaining lots, and performing exposure while controlling the position of the photosensitive object based on the estimate value of positional information of each of the plurality of divided areas and on the correction information that is latest, wherein the K is an integer not less than 2," as recited in independent claim 31, and as similarly recited in independent claims 50 and 61 (emphasis added).

An interview was conducted on the above-identified application on _____

NOTE:

This form should be completed by applicant and submitted to the examiner in advance of the interview (see MPEP § 713.01). This application will not be delayed from issue because of applicant's failure to submit a written record of this interview. Therefore, applicant is advised to file a statement of substance of this interview (37 CFR 1.133(b) as soon as possible.



(Applicant/Applicant's Representative Signature)

(Examiner/SPE Signature)